

SEARCHED			
Class	Subclass	Date	Examiner
606	4-6,10- 12,107,10 8,127,128, <i>167-171, 178</i>	6/22/2005	AF
607	88,89	6/22/2005	AF
604	20-22, 27 <i>28, 30</i>	6/22/2005	AF
600	398-402	6/22/2005	AF

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Same as	above	6/22/2005	AF

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Search; STIC search; and EAST search: Classification (IS&R); and Text (BRS)	6/22/2005	AF
Searched Data Basis: USPAT; USPGPUB; EPO; JPO; DERWENT; and IBM_TDB.	6/22/2005	AF
See the attached "Search History."	6/22/2005	AF